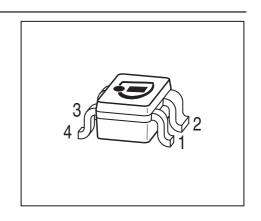


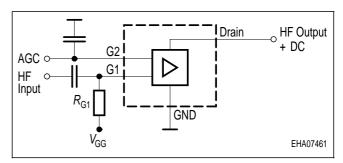
#### Silicon N-Channel MOSFET Tetrode

- Designed for input stages of UHF- and VHF-tuners with AGC function
- Supporting 5 V operations and power saving 3 V operations
- Integrated ESD gate protection diodes
- Very low noise figure
- High gain, high forward transadmittance
- Very good cross modulation at gain reduction
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101









ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Package	Pin Configuration					Marking	
BF5030	SOT143	1=S	2=D	3=G2	4=G1	-	-	KXs
BF5030R	SOT143R	1=D	2=S	3=G1	4=G2	-	-	KXs
BF5030W	SOT343	1=D	2=S	3=G1	4=G2	-	-	KXs

1



**Maximum Ratings** 

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{\mathrm{DS}}$	8	V
Continuous drain current	$I_{D}$	25	mA
Gate 1/ gate 2-source current	I <sub>G1S</sub> , I <sub>G2S</sub>	± 1	mA
Gate 1/ gate 2-source voltage	$V_{\rm G1S}, V_{\rm G2S}$	± 6	V
Total power dissipation	P <sub>tot</sub>		mW
<i>T</i> s ≤ 94 °C, BF5030W		200	
<i>T</i> s ≤ 76 °C, BF5030, BF5030R		200	
Storage temperature	T <sub>stg</sub>	-55 150	°C
Channel temperature	$T_{ch}$	150	

# **Thermal Resistance**

Parameter	Symbol	Value	Unit
Channel - soldering point <sup>1)</sup>	R <sub>thchs</sub>		K/W
BF5030W		≤ 280	
BF5030, BF5030R		≤ 370	

2

 $<sup>^{1}</sup>$ For calculation of  $R_{\mathrm{thJA}}$  please refer to Application Note Thermal Resistance



**Electrical Characteristics** at  $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics			•	,	•
Drain-source breakdown voltage	V <sub>(BR)DS</sub>	12	-	-	V
$I_{\rm D} = 20~\mu{\rm A},~V_{\rm G1S} = 0~,~V_{\rm G2S} = 0$					
Gate1-source breakdown voltage	+V <sub>(BR)G1SS</sub>	6	-	15	
$+I_{G1S} = 10 \text{ mA}, V_{G2S} = 0, V_{DS} = 0$	, ,				
Gate2-source breakdown voltage	+V <sub>(BR)G2SS</sub>	6	-	15	
$+I_{G2S} = 10 \text{ mA}, V_{G1S} = 0, V_{DS} = 0$					
Gate1-source leakage current	+/ <sub>G1SS</sub>	-	_	50	nA
$V_{\rm G1S} = 6 \text{ V}, \ V_{\rm G2S} = 0 \ , \ V_{\rm DS} = 0$					
Gate2-source leakage current	+/ <sub>G2SS</sub>	-	-	50	
$V_{\rm G2S} = 6 \text{ V}, \ V_{\rm G1S} = 0 \ , \ V_{\rm DS} = 0$					
Drain current	I <sub>DSS</sub>				
$V_{\rm DS}$ = 3 V, $V_{\rm G1S}$ = 0 , $V_{\rm G2S}$ = 3 V		-	-	100	
$V_{\mathrm{DS}}$ = 5 V, $V_{\mathrm{G1S}}$ = 0 , $V_{\mathrm{G2S}}$ = 4 V		-	-	100	
Drain-source current	I <sub>DSX</sub>				mA
$V_{\rm DS}$ = 3 V, $V_{\rm G2S}$ = 3 V, $R_{\rm G1}$ = 82 k $\Omega$		-	13	-	
$V_{\rm DS}$ = 5 V, $V_{\rm G2S}$ = 4 V, $R_{\rm G1}$ = 180 k $\Omega$		-	13	-	
Gate1-source pinch-off voltage	V <sub>G1S(p)</sub>				V
$V_{\rm DS}$ = 3 V, $V_{\rm G2S}$ = 3 V, $I_{\rm D}$ = 20 $\mu A$	,,,	-	0.7	-	
$V_{\rm DS}$ = 5 V, $V_{\rm G2S}$ = 4 V, $I_{\rm D}$ = 20 $\mu A$			0.7	_	
Gate2-source pinch-off voltage	V <sub>G2S(p)</sub>				
$V_{\rm DS}$ = 3 V, $V_{\rm G1S}$ = 3 V, $I_{\rm D}$ = 20 $\mu A$		_	0.7	-	
$V_{\rm DS}$ = 5 V, $V_{\rm G1S}$ = 4 V, $I_{\rm D}$ = 20 $\mu A$		_	0.7	_	

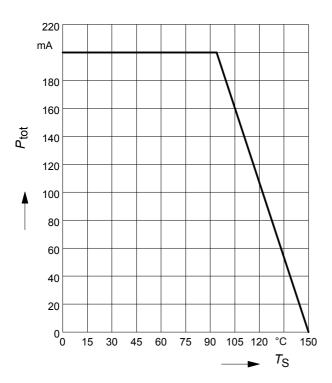


**Electrical Characteristics** at  $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics - (verified by random sampling	ng)	•			
Forward transconductance	$g_{fS}$				mS
$V_{\rm DS}$ = 3 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 3 V		-	41	-	
$V_{\rm DS}$ = 5 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 4 V		-	41	-	
Gate1 input capacitance	C <sub>g1ss</sub>				pF
$V_{\rm DS}$ = 3 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 3 V		-	2.7	-	
$V_{\rm DS}$ = 5 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 4 V		-	2.8	-	
Output capacitance	C <sub>dss</sub>				
$V_{\rm DS}$ = 3 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 3 V		-	1.6	_	
$V_{\rm DS}$ = 5 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 4 V		-	1.5	_	
Power gain	Gp				dB
$V_{\rm DS}$ = 3 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 3 V, $f$ = 800 MHz		_	24	_	
$V_{\rm DS}$ = 3 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 3 V, $f$ = 45 MHz		-	34	-	
$V_{\rm DS}$ = 5 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 4 V, $f$ = 800 MHz		-	24	_	
$V_{\rm DS}$ = 5 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 4 V, $f$ = 45 MHz		-	34	-	
Noise figure	F				dB
$V_{\rm DS}$ = 3 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 3 V, $f$ = 800 MHz		-	1.3	-	
$V_{\rm DS}$ = 3 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 3 V, $f$ = 45 MHz		-	0.9	-	
$V_{\rm DS}$ = 5 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 4 V, $f$ = 800 MHz		-	1.3	_	
$V_{\rm DS}$ = 5 V, $I_{\rm D}$ = 10 mA, $V_{\rm G2S}$ = 4 V, $f$ = 45 MHz		-	0.9	-	
Gain control range	$\Delta G_{p}$				
$V_{\rm DS}$ = 3 V, $V_{\rm G2S}$ = 30 V , $f$ = 800 MHz		45	50	_	
$V_{\text{DS}} = 5 \text{ V}, \ V_{\text{G2S}} = 40 \text{ V}, \ f = 800 \text{ MHz}$		45	50	_	
Cross-modulation $k=1\%$ , $f_W=50MHz$ , $f_{unw}=60MHz$	$X_{\text{mod}}$				dB
AGC = 0		90	94	_	
AGC = 10 dB		_	92	_	
AGC = 40 dB		96	98	_	



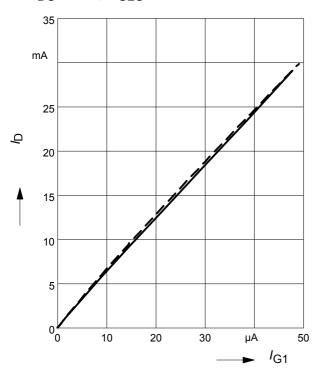
# Total power dissipation $P_{tot} = f(T_S)$ BF5030W



# **Drain current** $I_D = f(I_{G1})$

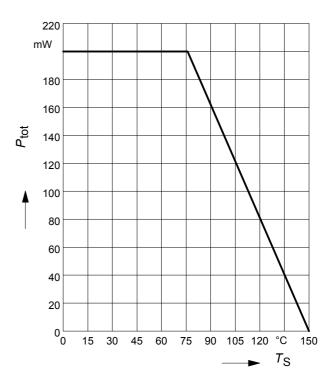
$$--V_{DS}$$
 = 3 V,  $V_{G2S}$  = 3 V

... 
$$V_{DS}$$
 = 5 V,  $V_{G2S}$  = 4 V



# Total power dissipation $P_{tot} = f(T_S)$

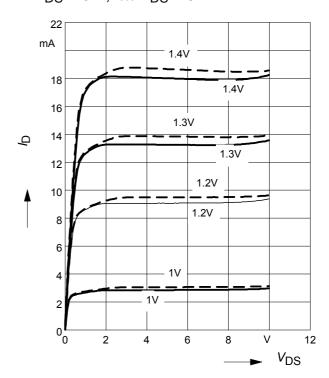
BF5030, BF5030R



# Output characteristics $I_D = f(V_{DS})$

$$V_{G1S}$$
 = Parameter

$$--V_{DS} = 3 \text{ V}, \dots V_{DS} = 5 \text{ V}$$

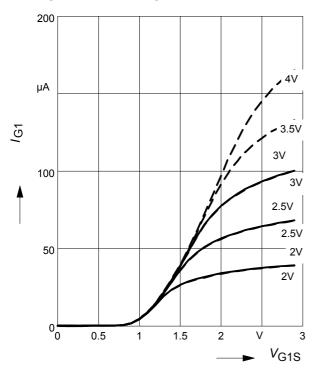




## Gate 1 current $I_{G1} = f(V_{G1S})$

 $V_{\rm G2S}$  = Parameter

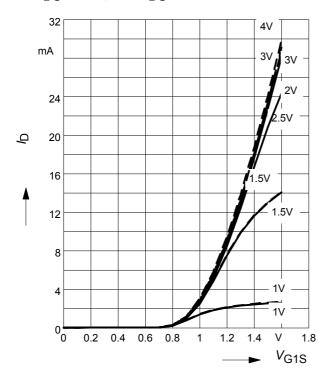
$$--V_{DS} = 3 \text{ V}, \dots V_{DS} = 5 \text{ V}$$



## **Drain current** $I_D = f(V_{G1S})$

 $V_{G2S}$  = Parameter

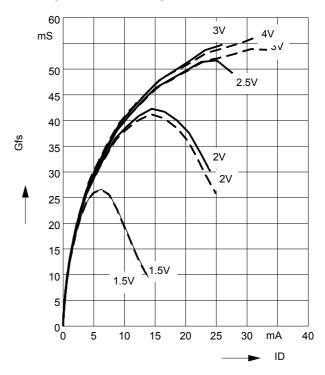
— 
$$V_{DS} = 3 \text{ V}, \dots V_{DS} = 5 \text{ V}$$



#### **Gate 1 forward transconductance**

 $g_{fs} = f(I_D), V_{G2S} = Parameter$ 

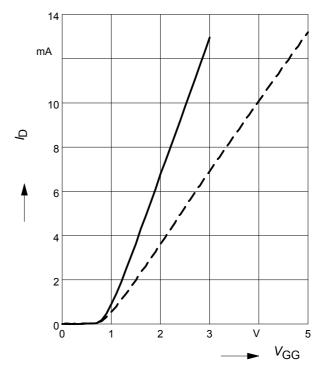
$$--V_{DS} = 3 \text{ V}, \dots V_{DS} = 5 \text{ V}$$



## **Drain current** $I_D = f(V_{GG})$

— 
$$V_{\rm DS}$$
 = 3 V,  $V_{\rm G2S}$  = 3 V,  $R_{\rm g1}$  = 82 k $\Omega$ 

... 
$$V_{\text{DS}}$$
 = 5 V,  $V_{\text{G2S}}$  = 4 V,  $R_{\text{g1}}$  = 180 k $\Omega$ 

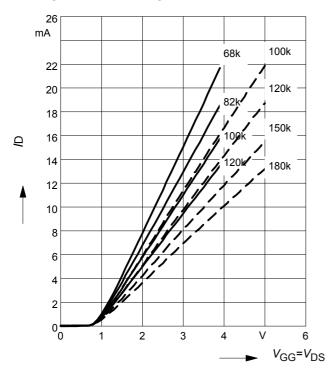




## **Drain current** $I_D = f(V_{GG})$

 $R_{G1}$  = Parameter in  $k\Omega$ 

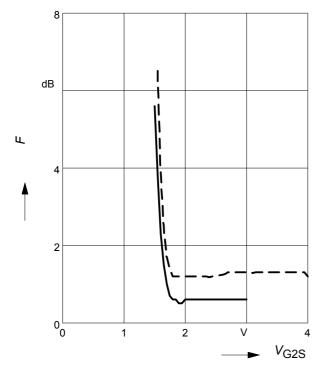
$$--V_{DS} = 3 \text{ V}, \dots V_{DS} = 5 \text{ V}$$



Noise figure  $F = f (V_{G2S}), f = 45 \text{ MHz}$ 

$$--V_{DS}$$
 = 3 V,  $V_{G2S}$  = 3 V,  $R_{g1}$  = 82 kΩ

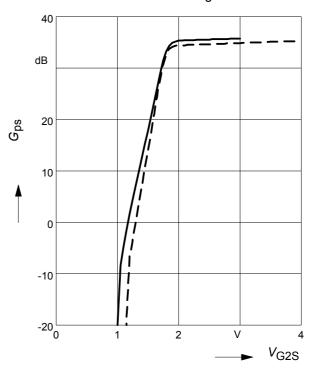
... 
$$V_{\mathrm{DS}}$$
 = 5 V,  $V_{\mathrm{G2S}}$  = 4 V,  $R_{\mathrm{g1}}$  = 180 k $\Omega$ 



Power gain  $G_{ps} = f(V_{G2S})$ , f = 45 MHz

— 
$$V_{DS}$$
 = 3 V,  $V_{G2S}$  = 3 V,  $R_{g1}$  = 82 kΩ

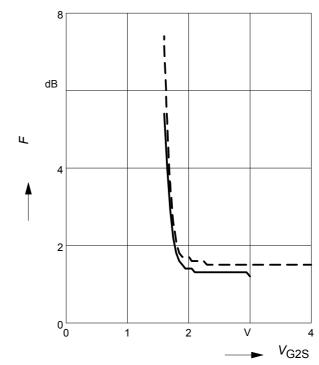
... 
$$V_{\text{DS}}$$
 = 5 V,  $V_{\text{G2S}}$  = 4 V,  $R_{\text{g1}}$  = 180 k $\Omega$ 



Noise figure  $F = f(V_{G2S}), f = 800 \text{ MHz}$ 

$$--V_{DS}$$
 = 3 V,  $V_{G2S}$  = 3 V,  $R_{g1}$  = 82 kΩ

... 
$$V_{\text{DS}}$$
 = 5 V,  $V_{\text{G2S}}$  = 4 V,  $R_{\text{g1}}$  = 180 k $\Omega$ 

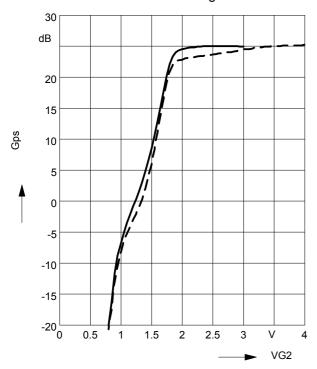




Power gain  $G_{ps} = f(V_{G2S})$ , f = 800 MHz

$$--V_{DS}$$
 = 3 V,  $V_{G2S}$  = 3 V,  $R_{g1}$  = 82 kΩ

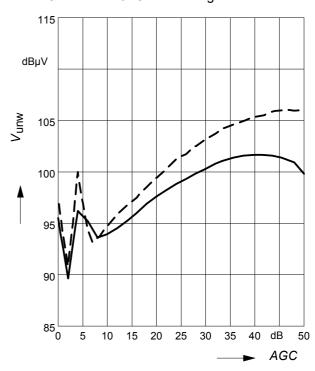
... 
$$V_{\text{DS}}$$
 = 5 V,  $V_{\text{G2S}}$  = 4 V,  $R_{\text{g1}}$  = 180 k $\Omega$ 



**Crossmodulation**  $V_{unw} = (AGC)$ 

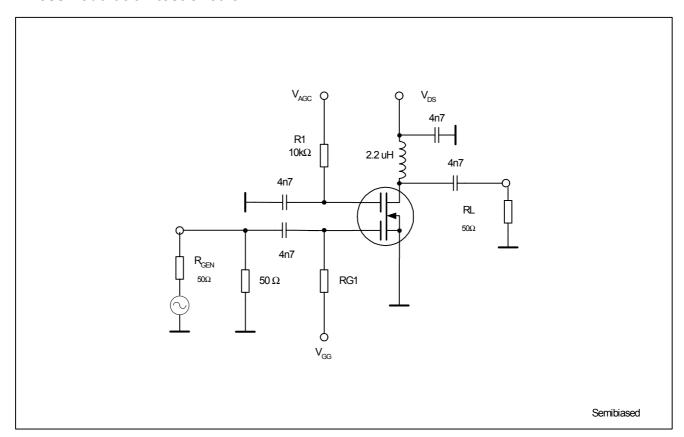
— 
$$V_{\rm DS}$$
 = 3 V,  $V_{\rm G2S}$  = 3 V,  $R_{\rm g1}$  = 82 k $\Omega$ 

... 
$$V_{\text{DS}}$$
 = 5 V,  $V_{\text{G2S}}$  = 4 V,  $R_{\text{g1}}$  = 180 k $\Omega$ 



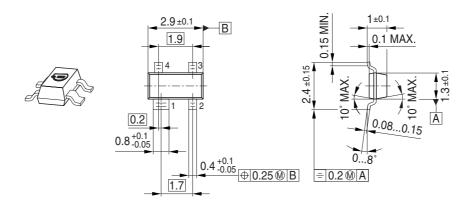


## **Crossmodulation test circuit**

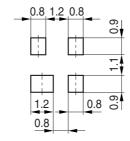




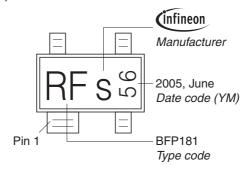
## Package Outline



#### Foot Print

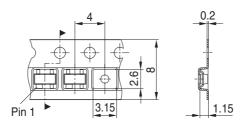


## Marking Layout (Example)



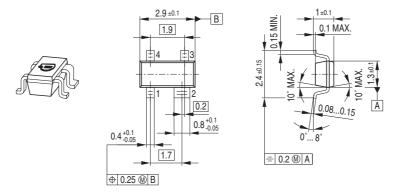
## Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel

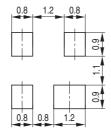




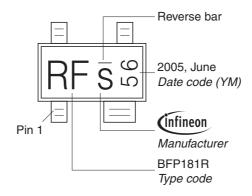
## Package Outline



#### Foot Print

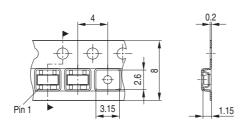


## Marking Layout (Example)



## Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel

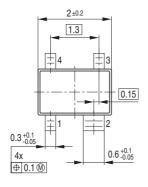


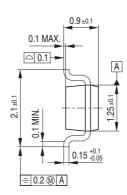
11



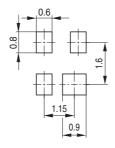
## Package Outline



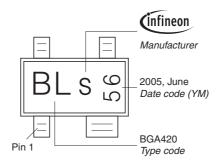




#### Foot Print

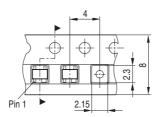


## Marking Layout (Example)



## Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel







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